

L Number	Hits	Search Text	DB	Time stamp
-	843	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and (passive or passivated)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/19 19:05
-	0	(((((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and (passive or passivated)) and reactive) and ((forming and breaking) adj bond) 09866533.ap.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/19 19:08
-	0	09866533.ap.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/20 15:24
-	0	2001us-9866533.ap.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/20 15:26
-	0	2001us-866533.ap.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/20 15:27
-	118	dip adj pen	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/20 15:27
-	7161	((250/307) or (250/492.2) or (250/492.3) or (73/105)).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/20 19:03
-	860	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (((250/307) or (250/492.2) or (250/492.3) or (73/105)).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/20 19:03
-	119	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (((250/307) or (250/492.2) or (250/492.3) or (73/105)).CCLS.)) and reactive	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/20 19:04

-		218	(((((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and (passive or passivated)) and reactive) and target	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/20 19:06
-		114	(((((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (((250/307) or (250/492.2) or (250/492.3) or (73/105)).CCLS.)) and reactive) not (((((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and (passive or passivated)) and reactive) and target)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/20 19:06
-		114	(((((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (((250/307) or (250/492.2) or (250/492.3) or (73/105)).CCLS.)) and reactive) not (((((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and (passive or passivated)) and reactive) and target)) or (((((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (((250/307) or (250/492.2) or (250/492.3) or (73/105)).CCLS.)) and reactive) not (((((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and (passive or passivated)) and reactive))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/20 19:07
-		3	5298760.URPN.	USPAT	2004/10/20 19:22
-		6	5116782.URPN.	USPAT	2004/10/20 19:27

	2	("6150235").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:03
	113	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (((250/307) or (250/492.2) or (250/492.3) or (73/105)).CCLS.) and reactive) not (((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and (passive or passivated)) and reactive)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:07
	2	("5352330").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 15:15
	1	"4578155".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:07
	1	"4595601".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:08
	1	"4605566".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:08
	1	"4606932".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:08
	1	"4608117".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:09
	1	"4612085".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:09
	1	"4615904".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:09
	1	"4624736".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:10
	1	"4810601".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:10
	1	"4834834".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:10
	1	"4994140".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:10
	1	"5015323".PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:11
	6	5352330.URPN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:19
	5900	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond) ((427/552) or (427/596)).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:50
	1046		USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:51

-		12	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ((427/552) or (427/596)).CCLS.) ("422").CLAS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:58
-		80031		USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:59
-		157	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ("422").CLAS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 12:59
-		157	((((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ("422").CLAS.)) not (((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ((427/552) or (427/596)).CCLS.)) ("427").CLAS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 13:06
-		139263		USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 13:07
-		457	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ("427").CLAS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 13:07

-	445	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ((427).CLAS.) not (((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ((427/552) or (427/596)).CCLS.))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 13:08
-	361	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and (passive or passivated)) and reactive (((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ((427).CLAS.) not (((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ((427/552) or (427/596)).CCLS.)) and (((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and (passive or passivated)) and reactive)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 13:15
-	30	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ((427).CLAS.) not (((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and ((427/552) or (427/596)).CCLS.)) and (((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (binding or bond)) and (passive or passivated)) and reactive)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 13:15
-	229	((438/676) or (438/771)).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 15:15
-	28929	(scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 15:17

-	11	((438/676) or (438/771)).CCLS.) and ((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) ("438").CLAS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 15:25
-	157842		USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 15:26
-	1392	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (("438").CLAS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 15:27
-	210	((scanning adj (tunneling or probe or capacitance or electrochemistry or (tunneling adj optical)) adj microscope) or (atomic adj force adj microscope) or ("near" adj field adj scanning adj (optical or acoustical) adj microscope) or stm or afm or spm or nsom or nsam or scm or secm) and (("438").CLAS.)) and (passivated or passivation)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/10/22 15:28
-	1	"5981316".PN.	USPAT; US-PGPUB	2004/10/22 15:53
-	1	"5689494".PN.	USPAT; US-PGPUB	2004/10/22 15:54
-	1	"5561300".PN.	USPAT; US-PGPUB	2004/10/22 16:00
-	1	"4987312".PN.	USPAT; US-PGPUB	2004/10/22 16:01
-	1	"4589191".PN.	USPAT; US-PGPUB	2004/10/22 16:02